# Data-Driven Optimization using Limited Data: the power of

Thomas Bayes (with high probability, this is him)





Parikshit Pareek



Sidhant Misra K



Kaarthik Sundar

Deep Deka Research Scientist,



#### Energy Infrastructure of the future: the case for **resilience**

- Renewables and smart devices are leading to a paradigm shift in grid operations.
  - Greater Variability/intermittent
  - Lesser inertia/stability
  - More measurements and data-driven capabilities
- Need: faster but risk-aware data-driven decision making





Smart but stochastic



#### Transmission Grid Optimization under uncertainty

**Optimal Power Flow**: minimize generation costs while satisfying injection/demand, technical constraints

#### Problem:





Non-linear power flow physics

#### Hard to Solve generally:

- Approximate analytical optimization (linear models, Gaussian uncertainty)
- ML surrogates + validation

**ML based:** Jalali, Pareek, Velloso, Zamzam, Singh, Kekatos, Baker, Bernstein, van- Hentenryck, Fioretto, Donti, Chatzivasileiadis, Misra, Nagarajan, Zhu, Qiu ....(incomplete)

#### Work-Flow for reliable grid decisions

Every 5-15 mins:





### Improvements in the Work-Flow

Every 5-15 mins:





- Optimization with Hard non-convex/ nonlinear constraints
- Needs to be solved fast
- Limited training data if system changes

#### Improvements in the Work-Flow

Every 5-15 mins:





• VOLTAGE is **implicit**, **non-linear** function of Injection



#### **Research Question:**

#### Every 5-15 mins:



a. Can we design ML optimization models that use limited data for solutions with confidence?

b. Can we design injection S  $\rightarrow$  voltage V map for faster risk assessment using limited data?

Solution: **Bayesian** machine learning a. Semi-supervised Bayesian Neural network for OPF b. Network-aware Gaussian Process for voltage maps

### **Research Question:**

Every 5-15 mins:



Parameters: w, input: x, output: y

a. Can we design ML optimization models that use limited data for solutions with confidence?

b. Can we design injection S → voltage V map for faster risk assessment using limited data?

Solution: **Bayesian** machine learning a. Semi-supervised Bayesian Neural network for OPF b. Network-aware Gaussian Process for voltage

maps<sub>Evaluate</sub> Posterior of parameters given prior and data

 $p(w|\mathbf{x},\mathbf{y}) \propto p(\mathbf{y}|\mathbf{x},w) p(w)$ 

 Estimate Posterior prediction of output for new input

$$p(\mathbf{y}^t | \mathbf{x}^t, \mathcal{D}) = \mathbb{E}_{p(w|\mathcal{D})}[p(f_w(\mathbf{x}^t))]$$

#### b. Can we design a data-driven input-output (injection S $\rightarrow$ voltage V) map?



Properties of a `good' approximator:

- Explicit  $S \rightarrow V$
- Easy to Evaluate, Differentiable
- Interpretable in terms of network structure
- Re-trainable/ transferable

#### Gaussian Process Regression for injection S $\rightarrow$ voltage V



Properties of a `good' approximator:

- Explicit  $S \rightarrow V$
- Easy to Evaluate, Differentiable
- Interpretable in terms of network structure
- Re-trainable/ transferable

• Non-parametric model for V as function of injection s

$$k(\mathbf{s}^{i}, \mathbf{s}^{j}) = \tau^{2} \exp\left\{\frac{-\|\mathbf{s}^{i} - \mathbf{s}^{j}\|^{2}}{2\ell^{2}}\right\}$$

Squared Exponential Kernel

#### Gaussian Process Regression for injection S $\rightarrow$ voltage V



• Non-parametric model for V as function of S

$$\begin{split} \widehat{V} &= f(\mathbf{s}) + \epsilon \\ f(\mathbf{s}^{i}) &\sim \mathcal{GP}\big( 0, k(\mathbf{s}^{i}, \mathbf{s}^{j}) \big) \\ \underline{\text{Zero Mean}} \quad \left( \begin{array}{c} \text{Kernel Function} \end{array} \right) \end{split}$$

$$k(\mathbf{s}^{i}, \mathbf{s}^{j}) = \tau^{2} \exp\left\{\frac{-\|\mathbf{s}^{i} - \mathbf{s}^{j}\|^{2}}{2\ell^{2}}\right\}$$

Squared Exponential Kernel



• Learn the Kernel parameters using Maximum Likelihood on training data

 $S = [\mathbf{s}^1 \dots \mathbf{s}^i \dots \mathbf{s}^N] \qquad \widehat{\mathbf{V}}_j = [V_j^1 \dots V_j^N]$ 

• Prediction for new injection sample

Mean:  $\mathbb{E}[f(\mathbf{s})] = V_j(\mathbf{s}) = \mathbf{k}^T [K + \sigma_{\epsilon}^2 I]^{-1} \widehat{\mathbf{V}}_j$ Variance:  $\sigma^2 [f(\mathbf{s})] = k(\mathbf{s}, \mathbf{s}) - \mathbf{k}^T [K + \sigma_{\epsilon}^2 I]^{-1} \mathbf{k}$ 

#### Network scale (Full) Gaussian Process is slow

• Prediction

 $\widehat{V} = f(\mathbf{s}) + \epsilon$ Mean :  $\mathbb{E}[f(\mathbf{s})] = V_j(\mathbf{s}) = \mathbf{k}^T [K + \sigma_{\epsilon}^2 I]^{-1} \widehat{\mathbf{V}}_j$ Variance :  $\sigma^2 [f(\mathbf{s})] = k(\mathbf{s}, \mathbf{s}) - \mathbf{k}^T [K + \sigma_{\epsilon}^2 I]^{-1} \mathbf{k}$ 

- No network dependance
- Scales as  $O(N^3)$  with samples
- Can we improve further?





500 random trials for 500-node network Testing 1000 out-of-sample data points.

## Vertex-Degree Kernel (VDK) GP

• Additive Kernels over nodeneighborhoods

$$k_v(\mathbf{s}^i,\mathbf{s}^j) = \sum_{b=1}^{|\mathcal{B}|} k_b(\mathbf{x}^i_b,\mathbf{x}^j_b)$$

- Why?
  - Neighboring injections have correlated effect on voltage
  - Effect of far away injections is approximately independent
- Dimension Reduction
  - Effective input dimension is max. vertex degree



Idea of Vertex Degree Kernel (VDK)



500 random trials for 500-node network Testing 1000 out-of-sample data points.

### VDK-GP with Active Learning (AL) for further gains!

• Select training samples iteratively to maximize information gain/variance

 $\mathbf{s}^{t+1} = \operatorname*{arg\,max}_{\mathbf{s}\in\mathcal{L}} [\sigma_f^t(\mathbf{s})]^2$ 

- Hard:
  - Finding maximum variance point for largedimensional input, non-trivial
- Network-swipe Active Learning (soln)
  - Leverage VDK-GP's structure for maximizing iteratively over graph hops
  - After a few hops, no Kernel overlap between nodes (can be <u>parallelized</u>)
  - Low-dimensional sub-kernels: numerical optimization works fine



Idea of Network-Swipe Active Learning

#### Performance in estimating voltage in test networks

• Sample needed: GP >> VDK-GP >> AL VDK-GP (GP much better than DNN)



**118-Bus system** with 1000 out of sample data points. AL requires ~45 samples



**500-Bus system** with 1000 out of sample data points. AL requires ~70 samples

### Violation Estimate (VE) using VDK-GP samples:



**Theorem 1.** Expected Value Estimation Error Bound: Given that voltage values, for any two arbitrary load vectors, are jointly Gaussian. Then,  $\mathbb{P}\{|V(\mathbf{s}) - \hat{V}(\mathbf{s})| \ge \varepsilon_m\} \le \delta(\kappa)$  where  $\hat{V}(\mathbf{s}) = \mu_f(\mathbf{s}^i) \pm \kappa \sigma_f(\mathbf{s})$  for any  $\varepsilon_m > 0$ . And with  $h(\cdot)$  being Sigmoid function, error in VE using GP is probabilistically bounded as

$$\mathbb{P}\Big\{ \left| VE - \widehat{VE} \right| < \varepsilon_m (1 - \delta(\kappa)) + M\delta(\kappa) + \varepsilon_h \Big\} \ge 1 - \beta$$

where,  $\beta \in (0,1)$ ,  $\varepsilon_h = \sqrt{\frac{\log(2/\beta)}{2N}}$ , M is a large value such that  $M > |h_p(\mathbf{s}) - h_m(\mathbf{s})|$ , and N is number of samples.

500 bus system, 95% confidence 20k AC-PF solves == 4205 sec 80k GP evaluations == 33.2 sec

(120x speedup), easily within grid operator limits

### Violation Estimate (VE) using VDK-GP samples:



|     | Samples   | Time(s) | VE      | $\Delta \mathrm{VE} 	imes 10^{-4}$ |
|-----|-----------|---------|---------|------------------------------------|
| 4   | 67 - 70   | 28 - 30 | -0.0018 | $7.8 \pm 0.5$                      |
| 181 | 71 - 76   | 30 - 33 | -0.0032 | $8.0 \pm 0.2$                      |
| 268 | 102 - 109 | 53 - 58 | +0.0008 | $7.9 \pm 0.2$                      |
| 320 | 72 - 76   | 30 - 33 | +0.0013 | $7.8 \pm 0.4$                      |
| 321 | 70 - 77   | 30 - 33 | +0.0021 | $6.8 \pm 0.5$                      |
|     |           |         |         |                                    |

- Mean evaluation time for 80100 samples is  $\approx 33.2$  sec

NRLF running time for 20025 samples is  $\approx 4205$  sec

 $\Delta VE$ : Difference in risk estimation using NRLF and AL-VDK  $\widehat{VE}$  is the mean across the 50 AL-VDK trials

#### **500 node grid**: 90 sec v/s 4200 sec (45x speedup)

|   | Samples   | Time(s)   | VE      | $\Delta { m VE} 	imes 10^{-4}$ |  |
|---|---|-----------|---------|--------------------------------|--|
| 183   | 77 - 81   | 159 - 168 | +0.0010 | $8.0 \pm 0.5$                  |  |
| 287   | 77 - 81   | 154 - 164 | +0.0009 | $8.2 \pm 0.2$                  |  |
| -   | Mean evaluation time for 8010 samples is $\approx 29.8$ sec |           |         |                                |  |
| -   | NRLF running time for 2025 samples is $\approx$ 3879 sec    |           |         |                                |  |
| $\Delta VE$ : Difference in risk estimation using NRLF and AL-VDK |   |           |         |                                |  |
| $\widehat{\text{VE}}$ is the mean across the 10 AL-VDK trials     |   |           |         |                                |  |

**1354 node grid:** 200 sec v/s 3870 sec (20x speedup)

[1] P Pareek, D Deka, S Misra, Fast Risk Assessment in Power Grids through Novel Gaussian Process and Active Learning, arXiv preprint arXiv:2308.07867.
 [2] P. Pareek, D. Deka, S. Misra, Data-Efficient Power Flow Learning for Network Contingencies. arXiv preprint arXiv:2310.00763.

### **Research Question:**

#### Every 5-15 mins:



a. Can we design ML optimization models that use limited data for solutions with confidence?

b. Can we design injection S  $\rightarrow$  voltage V map for faster risk assessment using limited data?

#### Solution: **Bayesian** machine learning

a. Semi-supervised Bayesian Neural network for OPF
b. Network-aware Gaussian Process for voltage
maps

#### ML proxy for OPF with *limited* training data

- Need optimal solution and constraint feasibility
- Standard ML proxies give point estimates for an input

$$\min \sum_{g \in \mathscr{G}} c(p_g)$$
s.t. 
$$\sum_{g \in \mathscr{G}_i} p_g - P_i = \sum_{j \in \mathscr{B}} v_i v_j (G_{ij} \cos(\theta_i - \theta_j) + B_{ij} \sin(\theta_i - \theta_j)) \quad \forall i \in \mathscr{B}$$

$$\sum_{g \in \mathscr{G}_i} q_g - Q_i = \sum_{j \in \mathscr{B}} v_i v_j (G_{ij} \sin(\theta_i - \theta_j) - B_{ij} \cos(\theta_i - \theta_j)) \quad \forall i \in \mathscr{B}$$

$$(p, q, v, \theta) \in \mathscr{T}$$

## ML proxy for OPF with *limited* training data

- Need optimal solution and constraint feasibility
- Standard ML proxies give point estimates for an input
- Goals:
  - ✓ Probabilistic solution with estimated confidence/variance
  - Overcome limited labeled data (for feasibility)
- Bayesian Neural Network (BNN) for OPF Proxy:



- Static weights
- Maximum Likelihood (MLE)



- Random weights (prior/posterior)
- Maximum Aposteriori (MAP)

 $\begin{array}{ll} \min_{\mathbf{y}} \ c(\mathbf{y}) \\ \text{s.t.} \ g(\mathbf{x},\mathbf{y}) = 0; \ h(\mathbf{x},\mathbf{y}) \leq 0 \end{array} \end{array}$ 

Labeled training data

$$p(\mathbf{y}|\mathbf{x}, w) = \prod_{i} \mathcal{N}(\mathbf{y}_{i}|f_{w}(\mathbf{x}_{i}), \sigma_{s}^{2})$$

$$p(w|\mathbf{x}, \mathbf{y}) \propto p(\mathbf{y}|\mathbf{x}, w) p(w)$$

Solved using variational inference (VI)

Jospin, Laurent Valentin, et al. "Hands-on Bayesian neural networks—A tutorial for deep learning users." *IEEE Computational Intelligence Magazine* 17.2 (2022): 29-48.

### ML proxy for OPF with *limited* training data

- Need optimal solution and constraint feasibility
- Standard ML proxies give point estimates for an input
- Goals:
  - ✓ Probabilistic solution with estimated confidence/variance
  - ✓ Overcome limited labeled data (for feasibility)
  - Bayesian Neural Network (BNN) for OPF Proxy:

$$\min_{\mathbf{y}} c(\mathbf{y})$$
s.t.  $g(\mathbf{x}, \mathbf{y}) = 0; h(\mathbf{x}, \mathbf{y}) \le 0$ 

Feasibility Enhancement

(unlabeled data, true value is 0)

$$\mathcal{L}(\mathbf{y}, \mathbf{x}) = \underbrace{\|g(\mathbf{x}, \mathbf{y})\|^2}_{\text{Equality Gap}} + \underbrace{\|\text{ReLU}[h(\mathbf{x}, \mathbf{y})]\|^2}_{\text{Inequality Gap}}$$
 $p(\mathcal{L}|\mathbf{x}, w) = \overline{\prod_j \mathcal{N}(0|\mathcal{L}(f_w(\mathbf{x}_j), \mathbf{x}_j), \sigma_u^2)}$ 

Labeled training data  $p(w|\mathbf{x}, \mathbf{y}) \propto p(\mathbf{y}|\mathbf{x}, w) p(w)$  $p(\mathbf{y}|\mathbf{x}, w) = \prod_i \mathcal{N}(\mathbf{y}_i | f_w(\mathbf{x}_i), \sigma_s^2)$ 

- Random weights (prior/posterior)
- Maximum Aposteriori (MAP)



• Semi-supervised Sandwiched training (optimality and feasibility):



 $\min_{\mathbf{y}} c(\mathbf{y}) \quad \text{s.t.} \quad g(\mathbf{x}, \mathbf{y}) = 0; \ h(\mathbf{x}, \mathbf{y}) \le 0$ 

- Preliminary results for 57 bus system:
  - Outperforms DNN at low labelled samples and low training time



1000 sec total training, 20k unsupervised samples, BNN on Numpyro, DNN on Pytorch



 $\min_{\mathbf{y}} c(\mathbf{y}) \quad \text{s.t.} \quad g(\mathbf{x}, \mathbf{y}) = 0; \ h(\mathbf{x}, \mathbf{y}) \le 0$ 

- Preliminary results for 57 bus system:
  - Outperforms DNN at low labelled samples and low training time

| Method                | Correction | Obj. Gap    | Mean Eq.    | Mean Ineq.  | Testing Time (s) |
|-----------------------|------------|-------------|-------------|-------------|------------------|
| Proposed              | No         | 0.02 (0.00) | 0.01 (0.00) | 0.00(0.00)  | 0.003 (0.000)    |
| BNN                   | No         | 0.04 (0.00) | 0.02 (0.00) | 0.00 (0.00) | 0.003 (0.000)    |
| DC3 [3]               | Yes        | 0.01 (0.00) | 0.00 (0.00) | 0.00 (0.00) | 0.089 (0.000)    |
| DC3, no soft loss [3] | Yes        | 0.70 (0.05) | 0.07 (0.00) | 0.03 (0.01) | 0.088 (0.000)    |
| Eq. NN [21]           | Yes        | 0.00 (0.00) | 0.00 (0.00) | 0.00 (0.00) | 0.039 (0.000)    |

100 test instances for 57-Bus, 1000 labeled samples, 1000 sec for training, no projection in BNN

[3] P. Donti, D. Rolnick, and J. Z. Kolter. Dc3: A learning method for optimization with hard constraints. In International Conference on Learning Representations, 2021.

[21] A. S. Zamzam and K. Baker. Learning optimal solutions for extremely fast ac optimal power flow. In 2020 IEEE international conference on communications, control, and computing technologies for smart grids (SmartGridComm), pages 1–6. IEEE, 2020.



# Next Steps:

#### Every 5-15 mins:



- a. Bayesian Neural networks for OPF
- More testing
- Use of confidence in follow up applications
- b. Network-aware GP for voltage modeling
  O Use in distribution grids (limited data)
- N-k applications
- Use BNN OPF confidence values to guide Monte Carlo or GP based validation of bounds (better than Hoeffding)

#### Co-authors:



Parikshit Pareek LANL



Sidhant Misra LANL



Kaarthik Sundar LANL

[1] P Pareek, D Deka, S Misra, Graph-Structured Kernel Design for Power Flow Learning using Gaussian Processes, arXiv preprint arXiv:2308.07867.

[2] P. Pareek, D. Deka, S. Misra, Data-Efficient Power Flow Learning for Network Contingencies. arXiv preprint arXiv:2310.00763.





Thank You. Questions!

#### Violation Estimate (VE) using VDK-GP samples:



|     | Samples  | Time(s) | ŶÊ      | $\Delta \mathrm{VE} 	imes 10^{-4}$ |  |
|-----|--|---------|---------|------------------------------------|--|
| 4   | 67 - 70  | 28 - 30 | -0.0018 | $7.8 \pm 0.5$                      |  |
| 181 | 71 - 76  | 30 - 33 | -0.0032 | $8.0 \pm 0.2$                      |  |
| 268 | 102 - 109  | 53 - 58 | +0.0008 | $7.9 \pm 0.2$                      |  |
| 320 | 72 - 76  | 30 - 33 | +0.0013 | $7.8 \pm 0.4$                      |  |
| 321 | 70 - 77  | 30 - 33 | +0.0021 | $6.8 \pm 0.5$                      |  |
|     | Mann analysis time for 80100 sementer is at 22.2 and |         |         |                                    |  |

- Mean evaluation time for 80100 samples is  $\approx 33.2$  sec

NRLF running time for 20025 samples is  $\approx$  4205 sec

 $\Delta VE$ : Difference in risk estimation using NRLF and AL-VDK  $\widehat{VE}$  is the mean across the 50 AL-VDK trials

**Theorem 2.** The GP-based predictive model overestimates probability of voltage violation i.e.  $\mathbb{P}\{h(\mathbf{s}) > 0\} \ge \widehat{\mathbb{P}}\{h_m(\mathbf{s}) > 0\}$  for  $\mathbf{s} \in S$ .

